

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,728	JAINEK ET AL.	
Examiner	Art Unit	
Benjamin Kurtz	1723	

	SEAR	CHED	
Class	Subclass	Date	Examiner
210	130 136 133 440 443 117 232	11/17/2005	вк
210	234	11/17/2005	ВК
137	115.18 151	11/17/2005	вк
137	903 910	11/17/2005	ВК
137	315.11	11/17/2005	ВК
137	251.1	11/17/2005	вк
137	315.33	11/17/2005	вк
137	454.2	11/17/2005	ВК
137	454.6	11/17/2005	вк
123	188.8	11/17/2005	ВК
220	203.23	11/17/2005	ВК
220	203.29	11/17/2005	вк

דאו	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner

(INCLUDING SE	ARCH STRATEG	(Y)
	DATE	EXMR
Wanda Walker	11/17/200	5 BK
Nathan Newhouse	11/17/2009	5 BK